

<b>Notice of References Cited</b>	Application/Control No. 10/734,252	Applicant(s)/Patent Under Reexamination WATKINSON, MICHAEL DAVID	
	Examiner Jacob F. Bétit	Art Unit 2164	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0041021	11-2001	Boyle et al.	382/305
*	B	US-2002/0059375	05-2002	Pivowar et al.	709/204
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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